## Notice of References Cited Application/Control No. 10/531,522 Examiner MANGTIN LIAN Applicant(s)/Patent Under Reexamination TATSUKAWA ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,229,425 B1	05-2001	Kobayashi, Hirofumi	336/200
*	В	US-2004/0084131 A1	05-2004	Konoue et al.	156/089.11
*	С	US-6,169,470 B1	01-2001	Ibata et al.	336/83
*	D	US-5,250,923	10-1993	Ushiro et al.	336/83
*	Е	US-6,504,466 B2	01-2003	Katsurada, Hisashi	336/200
*	F	US-6,621,400 B2	09-2003	Horie, Kenichi	336/200
*	G	US-6,597,270 B2	07-2003	Takashima et al.	336/83
*	Н	US-6,115,264	09-2000	Nosaka, Koji	361/821
*	I	US-5,392,019	02-1995	Ohkubo, Akira	336/200
*	J	US-6,194,248 B1	02-2001	Amaya et al.	438/110
*	К	US-2002/0140539 a1	10-2002	Takashima et al.	336/200
	- [	US-	7		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
4	R					
	s					
					100	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.